

1. Record Nr.	UNINA9910703289503321
Titolo	System voltage potential-induced degradation mechanisms in PV modules and methods for test [[electronic resource]] : preprint / / Peter Hacke ... [and others]
Pubbl/distr/stampa	[Golden, CO] : , : National Renewable Energy Laboratory, , [2011]
Descrizione fisica	1 online resource (7 pages) : illustrations (some color)
Collana	NREL/CP ; ; 5200-50716
Altri autori (Persone)	HackePeter
Soggetti	Photovoltaic power generation - Equipment and supplies - Service life Photovoltaic power systems - Reliability - Testing
Lingua di pubblicazione	Inglese
Formato	Materiale a stampa
Livello bibliografico	Monografia
Note generali	Title from title screen (viewed on Aug. 10, 2011). "July 2011." "Presented at the 37th IEEE Photovoltaic Specialists Conference (PVSC 37), Seattle, Washington, June 19-24, 2011."
Nota di bibliografia	Includes bibliographical references (pages 6-7).